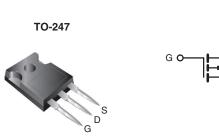
Vishay Siliconix

Power MOSFET

PRODUCT SUMMARY						
V _{DS} (V)	- 100					
R _{DS(on)} (Ω)	V _{GS} = - 10 V	0.20				
Q _g (Max.) (nC)	61					
Q _{gs} (nC)	14					
Q _{gd} (nC)	29					
Configuration	Single					



P-Channel MOSFET

FEATURES

- Dynamic dV/dt Rating
- Repetitive Avalanche Rated
- P-Channel
- Isolated Central Mounting Hole
- 175 °C Operating Temperature
- Fast Switching
- · Ease of Paralleling
- Lead (Pb)-free Available

DESCRIPTION

Third generation Power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The TO-247 package is preferred for commercial-industrial applications where higher power levels preclude the use of TO-220 devices. The TO-247 is similar but superior to the earlier TO-218 package because of its isolated mouting hole. It also provides greater creepage distance between pins to meet the requirements of most safety specifications.

ORDERING INFORMATION	
Package	TO-247
Lead (Pb)-free	IRFP9140PbF
	SiHFP9140-E3
SnPb	IRFP9140
	SiHFP9140

ABSOLUTE MAXIMUM RATINGS $T_{C} = 25 \text{ °C}$, unless otherwise noted						
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V _{DS}	- 100	V	
Gate-Source Voltage			V _{GS}	± 20	v	
Continuous Drain Current	V _{GS} at - 10 V	T _C = 25 °C		- 21		
	V _{GS} at - 10 V	$T_C = 100 \degree C$	I _D	- 15	A	
Pulsed Drain Current ^a			I _{DM}	- 84		
Linear Derating Factor			1.2	W/°C		
Single Pulse Avalanche Energy ^b			E _{AS}	960	mJ	
Repetitive Avalanche Current ^a			I _{AR}	- 21	A	
Repetitive Avalanche Energy ^a			E _{AR}	AR 18		
Maximum Power Dissipation	T _C = 25 °C		PD	180	W	
Peak Diode Recovery dV/dt ^c			dV/dt - 5.5		V/ns	
Operating Junction and Storage Temperature Range		T _J , T _{stg}	- 55 to + 175	°C		
Soldering Recommendations (Peak Temperature)) for 10 s 3		300 ^d			
Mounting Torque	6-32 or M3 screw			10	lbf ⋅ in	
			-	1.1	N · m	

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).

b. $V_{DD} = -25 \text{ V}$, starting $T_J = 25 \text{ °C}$, L = 3.3 mH, $R_G = 25 \Omega$, $I_{AS} = -21 \text{ A}$ (see fig. 12).

c. $I_{SD} \leq$ - 21 A, dl/dt \leq 200 A/µs, $V_{DD} \leq V_{DS}$, $T_J \leq$ 175 °C.

d. 1.6 mm from case.

* Pb containing terminations are not RoHS compliant, exemptions may apply



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THERMAL RESISTANCE RA	TINGS								
PARAMETER	SYMBOL	TYP.		MAX.		UNIT			
Maximum Junction-to-Ambient	R _{thJA}	-	- 40						
Case-to-Sink, Flat, Greased Surface	R _{thCS}	0.24 -				°C/W			
Maximum Junction-to-Case (Drain)	R _{thJC}	-							
SPECIFICATIONS $T_J = 25 \degree C$,	unless other	wise noted							
PARAMETER	SYMBOL				MIN.	TYP.	MAX.	UNIT	
Static	OTMBOL	1201	CONDITI		IVIII 4.		МАЛ.	UNIT	
Drain-Source Breakdown Voltage	V _{DS}	$V_{cc} = 0$	V, I _D = - 2	50 µA	- 100	-	_	v	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference to			-	- 0.087	-	v/°C	
Gate-Source Threshold Voltage	V _{GS(th)}		_{as} , I _D = - 2		- 2.0	-	- 4.0	V	
Gate-Source Leakage	I _{GSS}		$s = \pm 20$		-		± 100	v nA	
	IGSS	_	-		-	-	- 100	117	
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = - 100 V, V _{GS} = 0 V V _{DS} = - 80 V, V _{GS} = 0 V, T _J = 150 °C		-	-	- 500	μA		
Drain-Source On-State Resistance	R _{DS(on)}	$V_{\rm DS} = -00 V, V$ $V_{\rm GS} = -10 V$		= - 13 A ^b	-	_	0.20	Ω	
Forward Transconductance	g _{fs}	V _{DS} = - 5		- 13 A ^b	6.2	-	-	S	
Dynamic	010								
Input Capacitance	C _{iss}				-	1400	-		
Output Capacitance	C _{oss}	V _{GS} = 0 V, V _{DS} = - 25 V, f = 1.0 MHz, see fig. 5			-	590	-	pF	
Reverse Transfer Capacitance	C _{rss}				-	140	-		
Total Gate Charge	Qg				-	-	61	nC	
Gate-Source Charge	Q _{gs}	V _{GS} = - 10 V		A, $V_{DS} = -80 V$,	-	-	14		
Gate-Drain Charge	Q _{gd}	see fig. 6 and 13^{b}		-	-	29	_		
Turn-On Delay Time	t _{d(on)}				-	16	-		
Rise Time	t _r	- ., ., .,				73	-	ns	
Turn-Off Delay Time	t _{d(off)}	$V_{DD} = -50 V$, $I_D = -19 A$, $R_G = 9.1 \Omega$, $R_D = 2.4 \Omega$, see fig. 10^{b}			-	34	-		
Fall Time	t _f	-	· · · · · · · · · · · · · · · · · · ·			57	-		
Internal Drain Inductance	L _D	Between lead, 6 mm (0.25") from package and center of die contact			-	5.0	-	nH	
Internal Source Inductance	Ls				-	13	-		
Drain-Source Body Diode Characteristic	s								
Continuous Source-Drain Diode Current	I _S	MOSFET symbol showing the integral reverse p - n junction diode			-	-	- 21	A	
Pulsed Diode Forward Current ^a	I _{SM}				-	-	- 84		
Body Diode Voltage	V_{SD}	T_J = 25 °C, I_S = - 21 A, V_{GS} = 0 V ^b			-	-	- 5.0	V	
Body Diode Reverse Recovery Time	t _{rr}	- T _J = 25 °C, I _F = - 19 A, dl/dt = 100 A/µs ^b			-	130	260	ns	
Body Diode Reverse Recovery Charge	Q _{rr}				-	0.35	0.70	μC	
Forward Turn-On Time	t _{on}	Intrinsic turn	on time i	s negligible (turn	-on is dor	ninated by	y L _S and I	_D)	

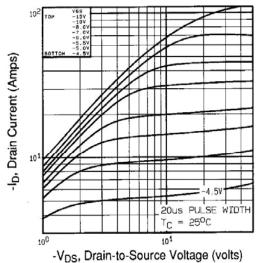
Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).

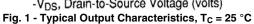
b. Pulse width \leq 300 $\mu s;$ duty cycle \leq 2 %.

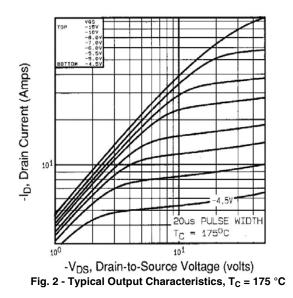


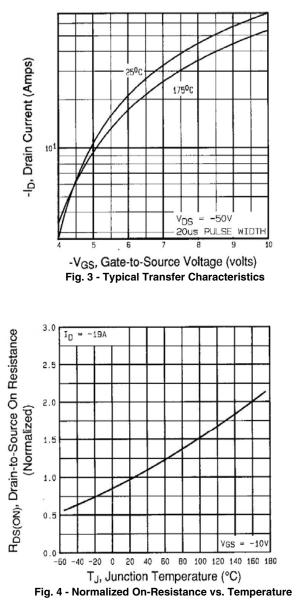
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TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted







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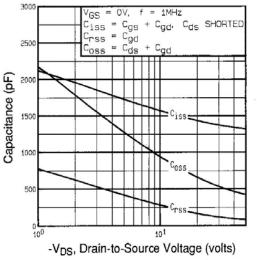


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

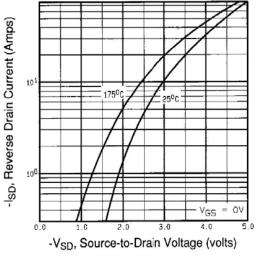


Fig. 7 - Typical Source-Drain Diode Forward Voltage

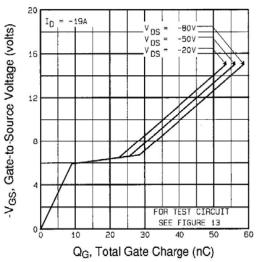
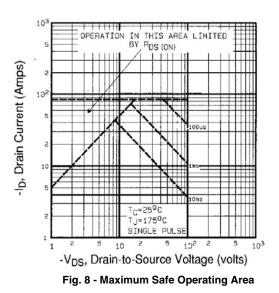


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage





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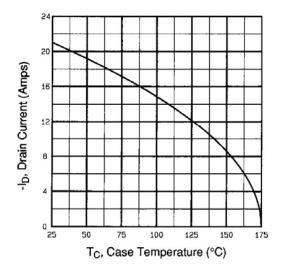


Fig. 9 - Maximum Drain Current vs. Case Temperature

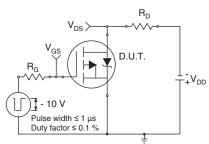


Fig. 10a - Switching Time Test Circuit

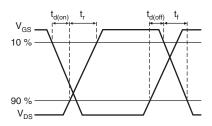
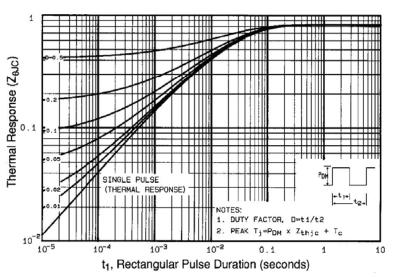


Fig. 10b - Switching Time Waveforms





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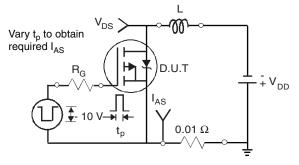
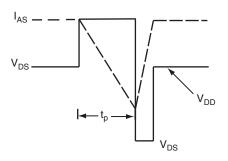
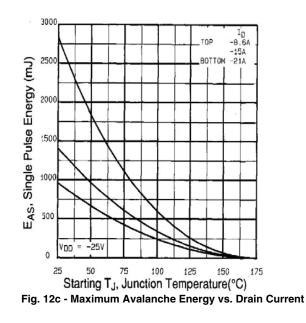


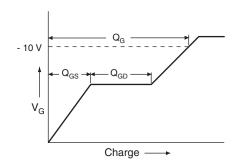
Fig. 12a - Unclamped Inductive Test Circuit



SHA

Fig. 12b - Unclamped Inductive Waveforms







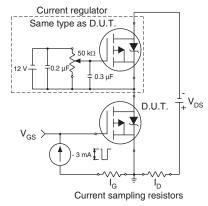
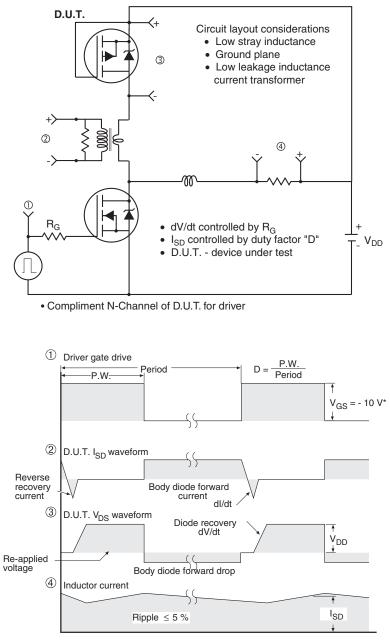


Fig. 13b - Gate Charge Test Circuit

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V_{GS} = - 5 V for logic level and - 3 V drive devices Fig. 14 - For P-Channel

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